

PMK30EP

P-channel TrenchMOS extremely low level FET

Rev. 02 — 25 February 2008

Product data sheet

1. Product profile

1.1 General description

P-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology.

1.2 Features

- Low threshold voltage
- Low R_{DSon}

1.3 Applications

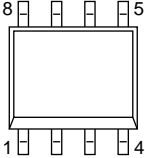
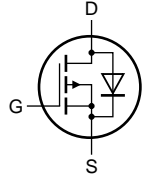
- Load switching
- Battery management

1.4 Quick reference data

- $V_{DS} \leq -30$ V
- $I_D \leq -14.9$ A
- $R_{DSon} \leq 19$ m Ω
- $Q_{GD} = 7$ nC (typ)

2. Pinning information

Table 1. Pinning

Pin	Description	Simplified outline	Symbol
1, 2, 3	source (S)		
4	gate (G)		
5, 6, 7, 8	drain (D)		

001aaa025

3. Ordering information

Table 2. Ordering information

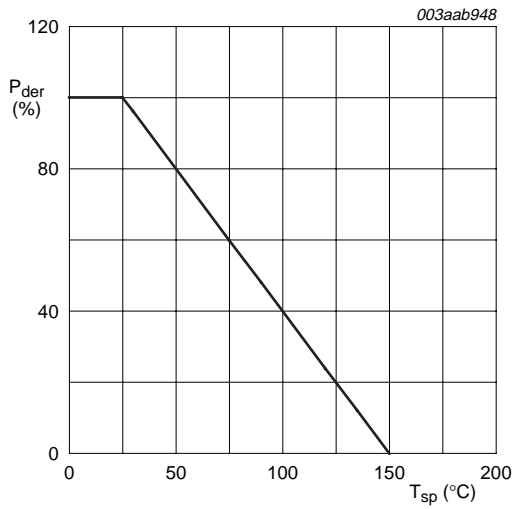
Type number	Package		Version
	Name	Description	
PMK30EP	SO8	SO8: plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1

4. Limiting values

Table 3. Limiting values

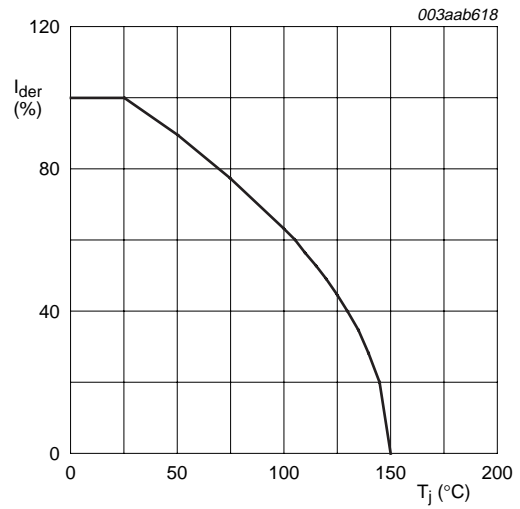
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$25\text{ °C} \leq T_j \leq 150\text{ °C}$	-	-30	V
V_{DGR}	drain-gate voltage (DC)	$25\text{ °C} \leq T_j \leq 150\text{ °C}$; $R_{GS} = 20\text{ k}\Omega$	-	-30	V
V_{GS}	gate-source voltage	-	-	± 20	V
I_D	drain current	$T_{sp} = 25\text{ °C}$; $V_{GS} = -10\text{ V}$; see Figure 2 and 3	-	-14.9	A
		$T_{sp} = 100\text{ °C}$; $V_{GS} = -10\text{ V}$; see Figure 2	-	-7.5	A
I_{DM}	peak drain current	$T_{sp} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$; see Figure 3	-	-28.8	A
P_{tot}	total power dissipation	$T_{sp} = 25\text{ °C}$; see Figure 1	-	6.9	W
T_{stg}	storage temperature	-	-55	+150	°C
T_j	junction temperature	-	-55	+150	°C
Source-drain diode					
I_S	source current	$T_{sp} = 25\text{ °C}$	-	-5.8	A
I_{SM}	peak source current	$T_{sp} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$	-	-23	A



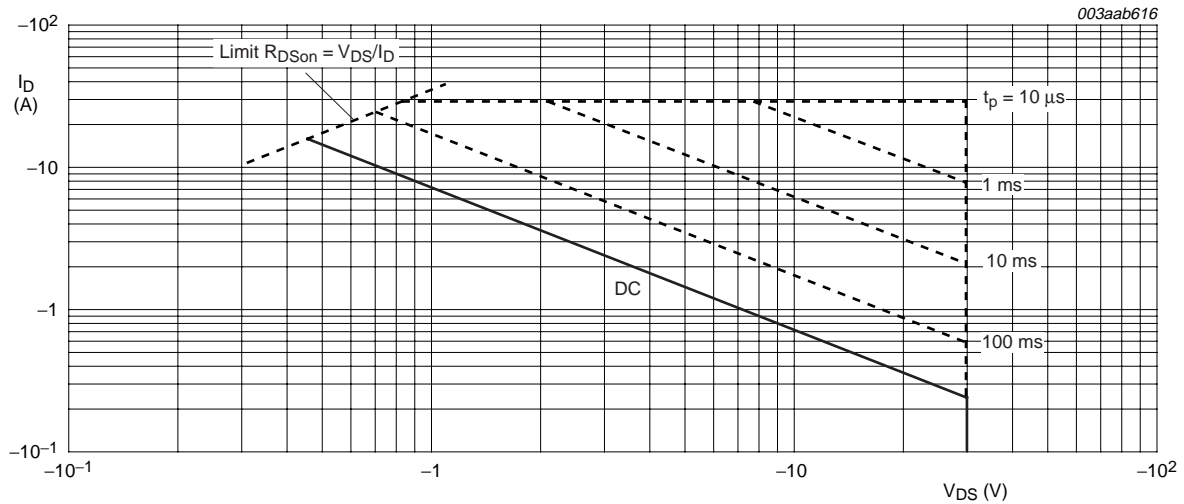
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

Fig 1. Normalized total power dissipation as a function of solder point temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$

Fig 2. Normalized continuous drain current as a function of solder point temperature



$T_{sp} = 25^{\circ}C$; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	see Figure 4	-	-	18	K/W

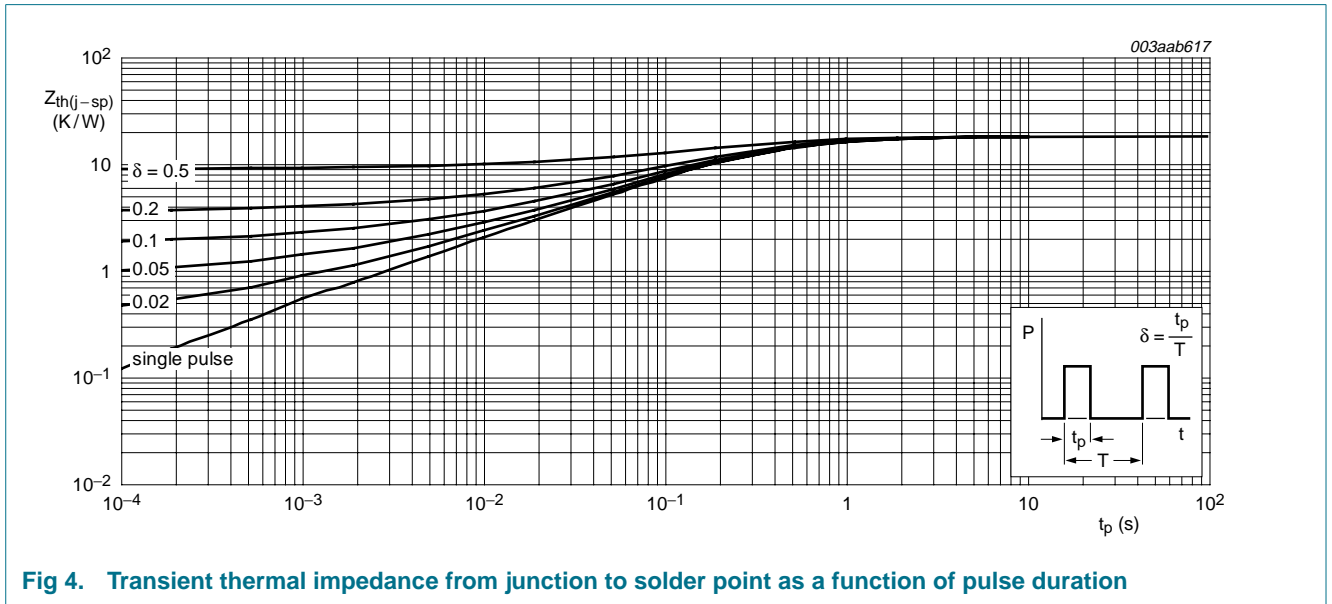


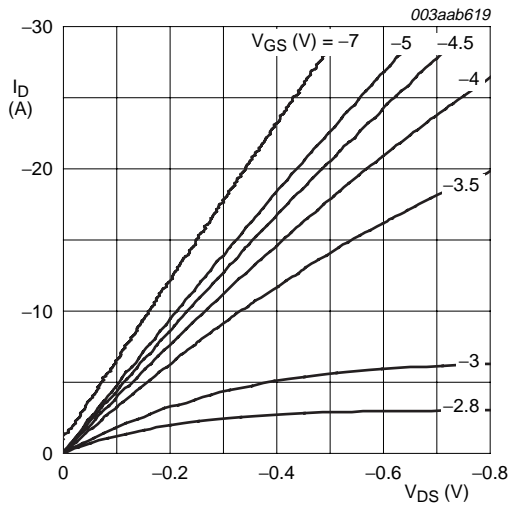
Fig 4. Transient thermal impedance from junction to solder point as a function of pulse duration

6. Characteristics

Table 5. Characteristics

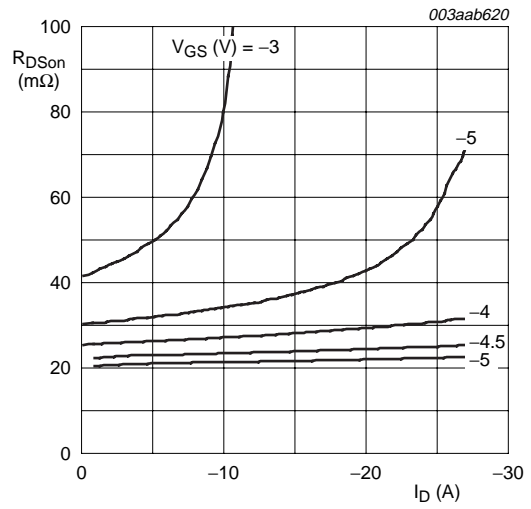
$T_j = 25\text{ °C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = -250\ \mu\text{A}$; $V_{GS} = 0\ \text{V}$ $T_j = 25\text{ °C}$	-30	-	-	V
		$T_j = -55\text{ °C}$	-27	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = -250\ \mu\text{A}$; $V_{DS} = V_{GS}$; see Figure 9 and 10 $T_j = 25\text{ °C}$	-1	-	-3	V
		$T_j = 150\text{ °C}$	-0.7	-	-	V
		$T_j = -55\text{ °C}$	-	-	-3.3	V
I_{DSS}	drain leakage current	$V_{DS} = -30\ \text{V}$; $V_{GS} = 0\ \text{V}$ $T_j = 25\text{ °C}$	-	-	-1	μA
		$T_j = 70\text{ °C}$	-	-	-10	μA
I_{GSS}	gate leakage current	$V_{GS} = \pm 16\ \text{V}$; $V_{DS} = 0\ \text{V}$	-	-	-100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = -10\ \text{V}$; $I_D = -9.2\ \text{A}$; see Figure 8 $T_j = 25\text{ °C}$	-	16	19	m Ω
		$T_j = 150\text{ °C}$	-	25	31	m Ω
		$V_{GS} = -4.5\ \text{V}$; $I_D = -7.3\ \text{A}$; see Figure 6 and 8	-	24	30	m Ω
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	$I_D = -9.2\ \text{A}$; $V_{DS} = -15\ \text{V}$; $V_{GS} = -10\ \text{V}$; see Figure 11 and 12	-	50	-	nC
Q_{GS}	gate-source charge		-	7	-	nC
Q_{GD}	gate-drain charge		-	7	-	nC
$V_{GS(pl)}$	gate-source plateau voltage		-	-2.5	-	V
C_{iss}	input capacitance	$V_{GS} = 0\ \text{V}$; $V_{DS} = -25\ \text{V}$; $f = 1\ \text{MHz}$; see Figure 14	-	2240	-	pF
C_{oss}	output capacitance		-	325	-	pF
C_{riss}	reverse transfer capacitance		-	220	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = -15\ \text{V}$; $R_L = 6\ \Omega$; $V_{GS} = -10\ \text{V}$; $R_G = 6\ \Omega$	-	10	-	ns
t_r	rise time		-	8	-	ns
$t_{d(off)}$	turn-off delay time		-	56	-	ns
t_f	fall time		-	21	-	ns
Source-drain diode						
V_{SD}	source-drain voltage	$I_S = -3.45\ \text{A}$; $V_{GS} = 0\ \text{V}$; see Figure 13	-	-0.8	-1.2	V



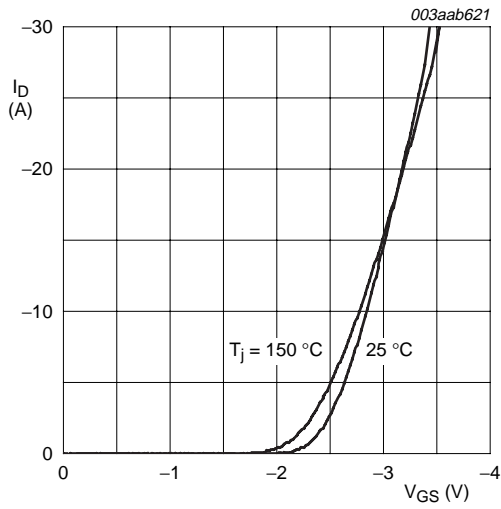
$T_j = 25\text{ }^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



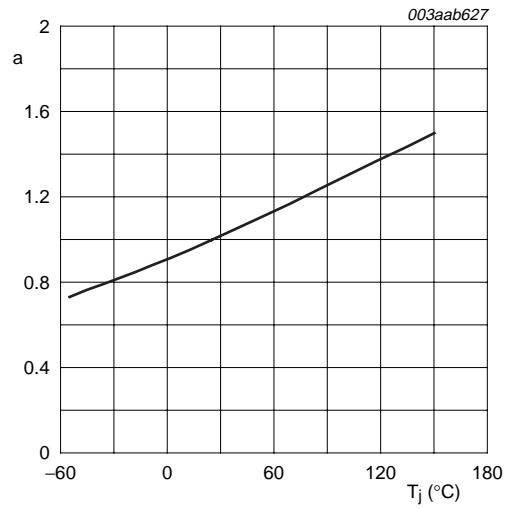
$T_j = 25\text{ }^\circ\text{C}$

Fig 6. Drain-source on-state resistance as a function of drain current; typical values



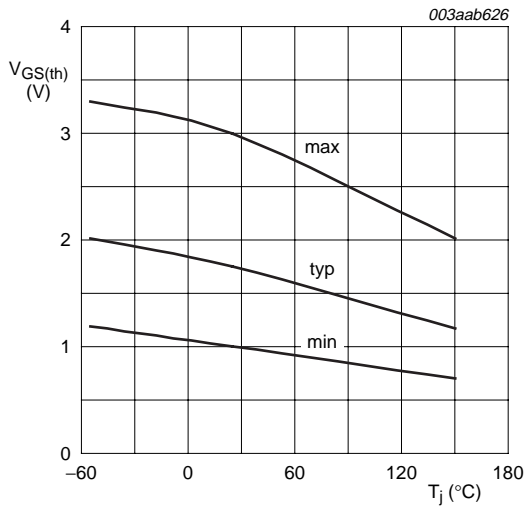
$T_j = 25\text{ }^\circ\text{C}$ and $150\text{ }^\circ\text{C}$; $V_{DS} > I_D \times R_{DSon}$

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values



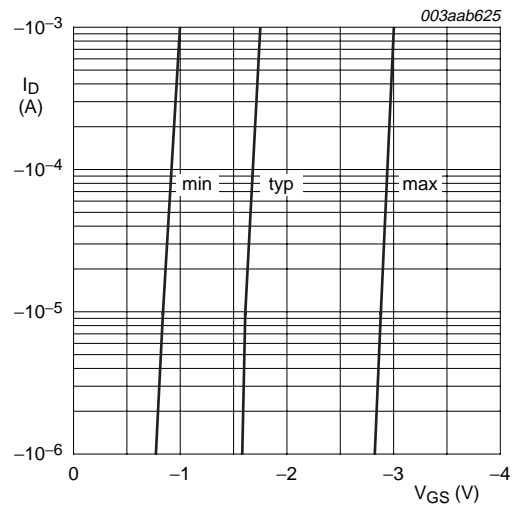
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



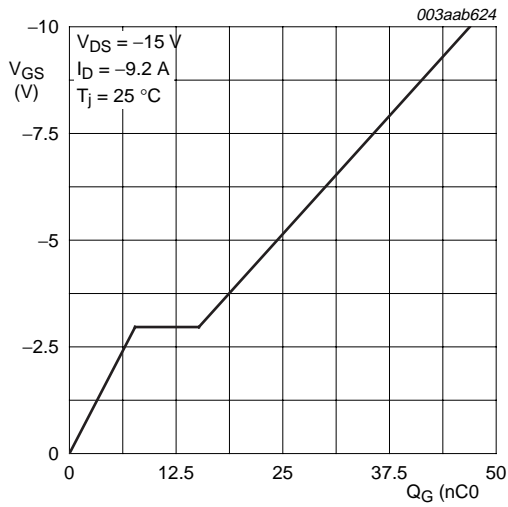
$I_D = -1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



$T_j = 25 \text{ }^\circ\text{C}; V_{DS} = -5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



$I_D = -9.2 \text{ A}; V_{DS} = -15 \text{ V}$

Fig 11. Gate-source voltage as a function of gate charge; typical values

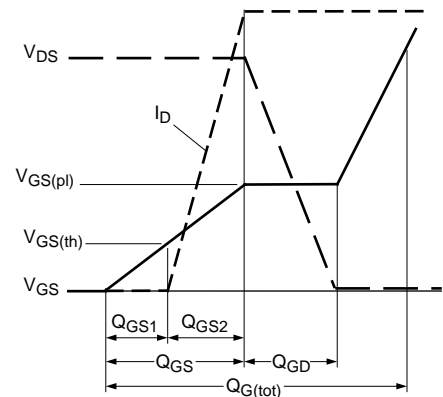
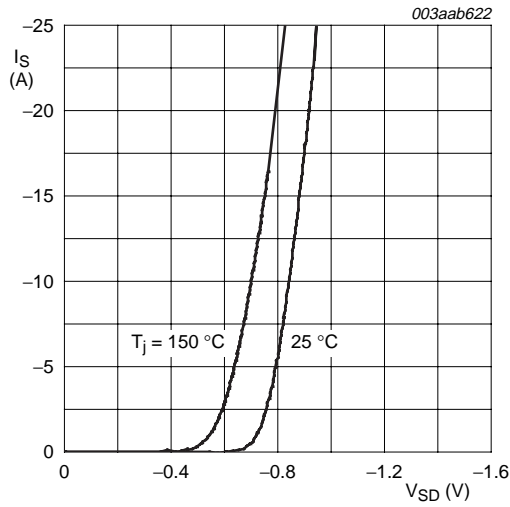
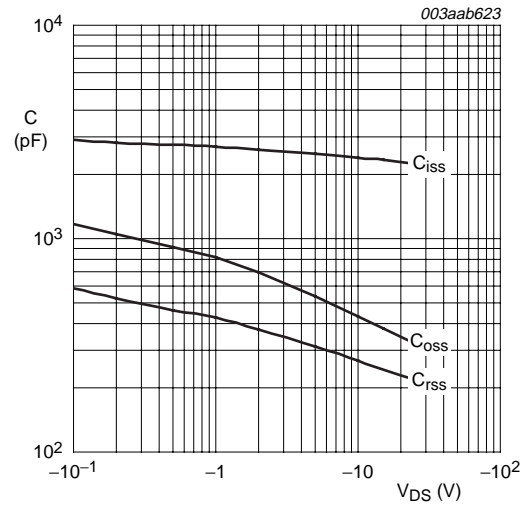


Fig 12. Gate charge waveform definitions



$T_j = 25^\circ\text{C}$ and 150°C ; $V_{GS} = 0\text{V}$

Fig 13. Source current as a function of source-drain voltage; typical values



$V_{GS} = 0\text{V}$; $f = 1\text{MHz}$

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

7. Package outline

SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1

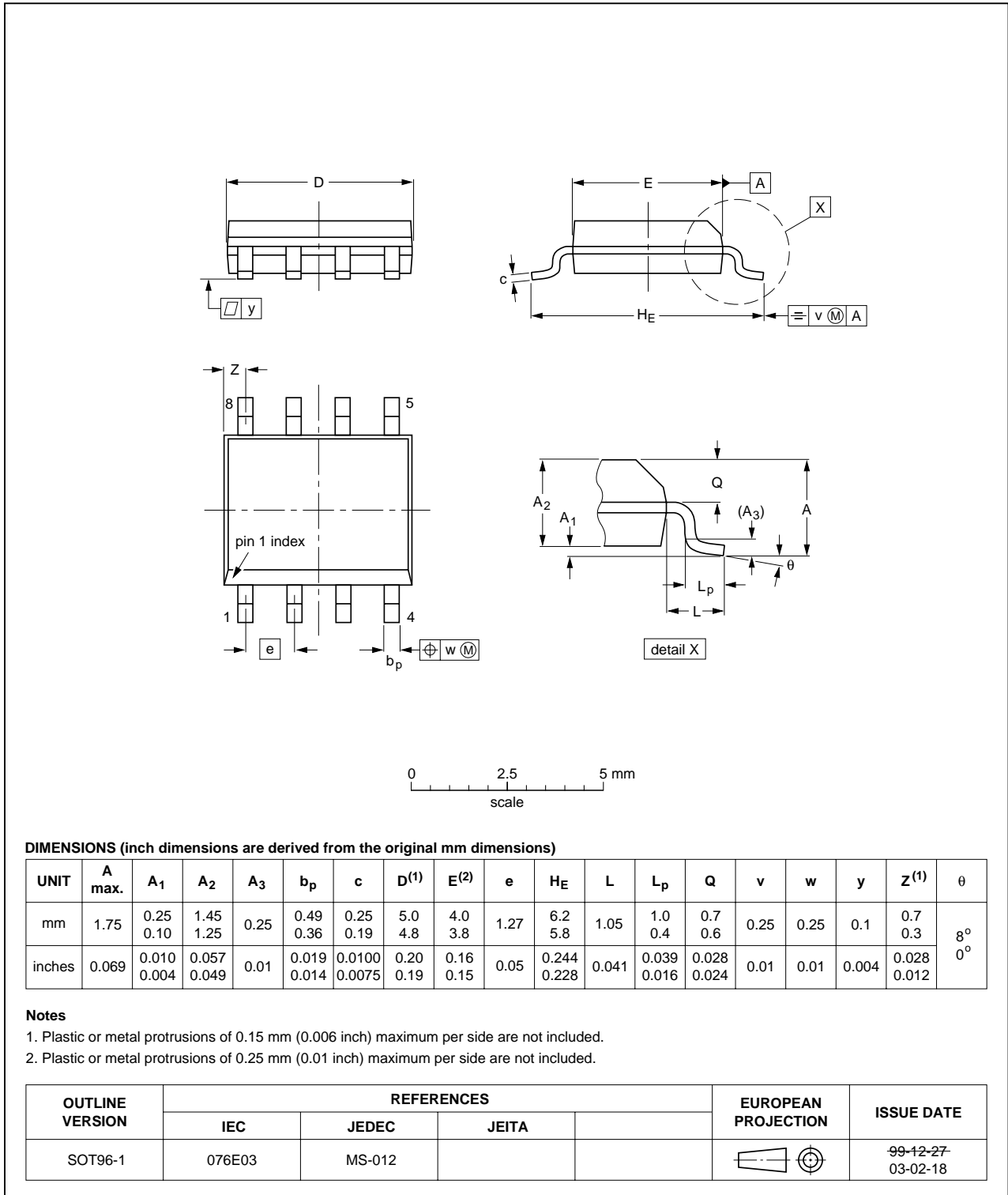


Fig 15. Package outline SOT96-1 (SO8)

8. Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMK30EP_2	20080225	Product data sheet	-	PMK30EP_1
Modifications:	<ul style="list-style-type: none">• The value for I_D in Section 1.4 was updated.• The value for Q_{GD} in Section 1.4 was updated.			
PMK30EP_1	20070917	Product data sheet	-	-

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9.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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